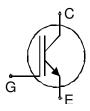


High Speed IGBT Chip in NPT-technology

FEATURES:

- low Eoff
- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

- This chip is used for:
- SGP30N60HS
- **Applications:**
- Welding
- PFC
- UPS



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC25T60UN	600V	30A	4.5 x 5.71 mm ²	sawn on foil	Q67041-A4667- A001

MECHANICAL PARAMETER:

		mm ²		
Raster size	4.5 x 5.71			
Area total / active	25.7 / 20.7			
Emitter pad size	2x(2.18x1.58)			
Gate pad size	1.08 x 0.68			
Thickness	100	μm		
Wafer size	150	mm		
Flat position	90	deg		
Max.possible chips per wafer	566			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	AI, ≤500µm			
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	1)	A
Pulsed collector current, t_p limited by T_{jmax}	I _{cpuls}	90	A
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T _j , T _{stg}	-55 +150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
		oonaniona	min.	typ.	max.	onit
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V, I _C =500µA	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =30A		2.8	3.15	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I_C =300µA, V_{GE} = V_{CE}	3	4	5	
Zero gate voltage collector current	I _{CES}	V_{CE} =600V, V_{GE} =0V			2	μA
Gate-emitter leakage current	I _{GES}	V_{CE} =0V, V_{GE} =20V			120	nA

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
	Cymbol		min.	typ.	max.	
Input capacitance	Ciss	<i>V</i> _{CE} =25V	-	1500		pF
Output capacitance	Coss	V _{GE} =0V <i>f</i> =1MHz	-	150		
Reverse transfer capacitance	Crss		-	92		

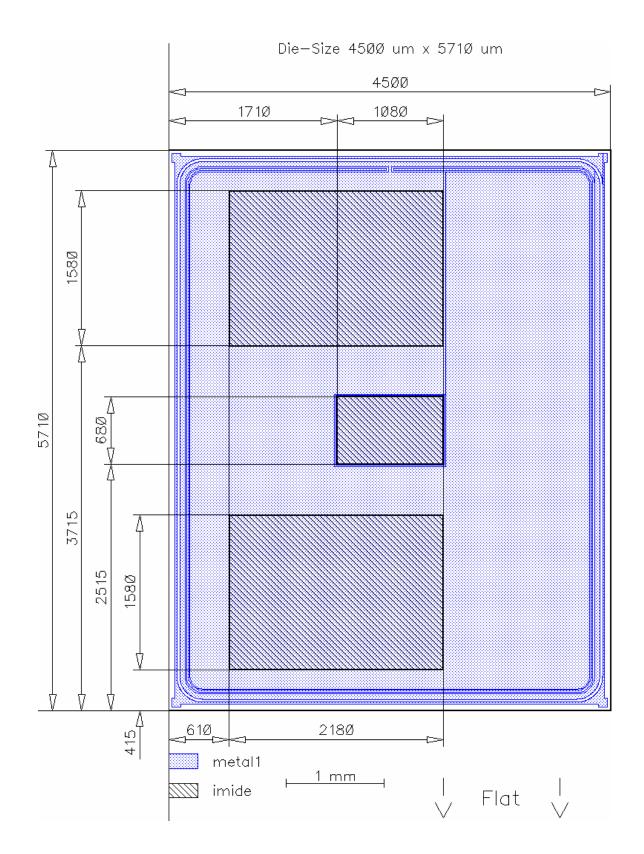
SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions ¹⁾	Value			Unit
			min.	typ.	max.	Unit
Turn-on delay time	t _{d(on)}	$T_{\rm j}$ =150°C	-	16		ns
Rise time	t _r	$V_{\rm CC} = 400 V$	-	13		
Turn-off delay time	$t_{d(off)}$	· / _C =30A V _{GE} =+15/0V	-	122		
Fall time	t _f	$R_{\rm G}$ =1.8 Ω	-	29		

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:



Edited by INFINEON Technologies AI PS DD HV3, L 7262-U, Edition2, 28.11.2003



FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

SGP30N60HS

Package :TO220

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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